

### SLOVENSKI STANDARD SIST EN 61547:2009

01-oktober-2009

BUXca Yý U. SIST EN 61547:1996

SIST EN 61547:1996/A1:2002

### Oprema za splošno razsvetljavo - Zahteve za odpornost proti EMC (IEC 61547:2009)

Equipment for general lighting purposes - EMC immunity requirements (IEC 61547:2009)

Einrichtungen für allgemeine Beleuchtungszwecke EMV-Störfestigkeitsanforderungen (IEC 61547:2009) (standards.iteh.ai)

Equipements pour l'éclairage à usage général 54 Éxigences concernant l'immunité CEM (CEI 61547:2009) https://standards.iteh.ai/catalog/standards/sist/eb/73a434-ac23-4d7d-963f-d9cf1264401c/sist-en-61547-2009

Ta slovenski standard je istoveten z: EN 61547:2009

ICS:

29.140.01 Žarnice na splošno Lamps in general

33.100.20 Imunost Immunity

SIST EN 61547:2009 en,fr

**SIST EN 61547:2009** 

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SIST EN 61547:2009

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**EUROPEAN STANDARD** 

EN 61547

NORME EUROPÉENNE EUROPÄISCHE NORM

August 2009

ICS 29.020; 29.140; 33.100.10

Supersedes EN 61547:1995 + A1:2000

English version

## **Equipment for general lighting purposes - EMC immunity requirements**

(IEC 61547:2009)

Equipements pour l'éclairage à usage général -Exigences concernant l'immunité CEM (CEI 61547:2009) Einrichtungen für allgemeine Beleuchtungszwecke -EMV-Störfestigkeitsanforderungen (IEC 61547:2009)

This European Standard was approved by CENELEC on 2009-07-01. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

https://standards.iteh.ai/catalog/standards/sist/eb73a434-ac23-4d7d-963f-

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Bulgaria, Cyprus, the Czech Republic, Denmark, Estonia, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Latvia, Lithuania, Luxembourg, Malta, the Netherlands, Norway, Poland, Portugal, Romania, Slovakia, Slovenia, Spain, Sweden, Switzerland and the United Kingdom.

### **CENELEC**

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: Avenue Marnix 17, B - 1000 Brussels

#### **Foreword**

The text of document 34/127/FDIS, future edition 2 of IEC 61547, prepared by IEC TC 34, Lamps and related equipment, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61547 on 2009-07-01.

This European Standard supersedes EN 61547:1995 + A1:2000.

The main reason for this revision is to update the dates of the references to the basic standards which also required some editorial changes in the tables. Other changes are:

- 1 Scope: clearly excludes multimedia equipment with lamps (e.g. TV);
- 3.2 Enclosure port: removal of the "earth port" in Figure 1 as in the generic EMC standards; the note below Figure 1 in EN 61547:1995 relates to a requirement and moved to the main text under 5.1 General;
- 5.6 Injected currents: update of the names of the example CDN's;
- 5.7 Surges: test only at the peak of the mains voltage by deleting the requirement to test at zero crossings;
- 5.8 Voltage dips and interruptions: clarifying that the voltage level changes at the zero crossing;
- 6.3.2 Independent auxiliaries: Table 14 has been simplified because most independent auxiliaries have identical performance criteria;
- 6.3.3 Luminaires: Table 15 has been simplified because most luminaires have identical performance criteria; correcting the error in the injected current column by changing the B into A for luminaires with electronic ballast for discharge lamps; additionally, the requirements for emergency luminaires operating in high risk task areas are updated to meet the levels specified in EN 60598-2-22;
- Conditions during testing the funder consideration of the operating conditions for starting devices has been deleted; the supply voltage and frequency during the test are clearly stated; shortening the immunity test for equipment incorporating a regulating control by testing at one light output level (50 % ± 10 %) instead of testing at three light output levels which are difficult to adjust and do not provide extra protection.

This standard is to be read in conjunction with the relevant basic and/or product standard(s).

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 2010-04-01

 latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2012-07-01

This European Standard has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association and covers essential requirements of EC Directive EMC (2004/108/EC). See Annex ZZ.

Annexes ZA and ZZ have been added by CENELEC.

#### **Endorsement notice**

The text of the International Standard IEC 61547:2009 was approved by CENELEC as a European Standard without any modification.

## Annex ZA (normative)

## Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60050-161	_1)	International Electrotechnical Vocabulary (IEV) - Chapter 161: Electromagnetic compatibility	-	-
IEC 60050-845	_1)	International Electrotechnical Vocabulary (IEV) - Chapter 845: Lighting	-	-
IEC 60598-1 (mod)	2008	Luminaires - Part 1: General requirements and tests	EN 60598-1 A11	2008 2009
IEC 60598-2-22 (mod)	_1)  iT(	Luminaires - Part 2-22: Particular requirements EVIE  Luminaires for emergency lighting	EN 60598-2-22 + corr. October	1998 <sup>2)</sup> 2007
IEC 61000-4-2	2008	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test SIST EN 61547:2009		2009
IEC 61000-4-3 A1	2006 2007	ndards iteh ai/catalog/standards/sist/eb73a434-ac23-4d7 Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test	d-963F EN 61000-4-3 A1 IS1	2006 2008 2009
IEC 61000-4-4	2004	Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test	EN 61000-4-4	2004
IEC 61000-4-5	2005	Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test	EN 61000-4-5	2006
IEC 61000-4-6	2008	Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	EN 61000-4-6	2009
IEC 61000-4-8 A1	1993 2000	Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test	EN 61000-4-8 A1	1993 2001

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<sup>1)</sup> Undated reference.

<sup>&</sup>lt;sup>2)</sup> Valid edition at date of issue.

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<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 61000-4-11	2004	Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests	EN 61000-4-11	2004
IEC 61000-6-1	2005	Electromagnetic compatibility (EMC) - Part 6-1: Generic standards - Immunity for residential, commercial and light-industrial environments	EN 61000-6-1	2007

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### Annex ZZ (informative)

#### **Coverage of Essential Requirements of EC Directives**

This European Standard has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association and within its scope the standard covers all relevant essential requirements as given in Annex I of the EC Directive 2004/108/EC.

Compliance with this standard provides one means of conformity with the specified essential requirements of the Directive concerned.

WARNING: Other requirements and other EC Directives may be applicable to the products falling within the scope of this standard.

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<u>SIST EN 61547:2009</u> https://standards.iteh.ai/catalog/standards/sist/eb73a434-ac23-4d7d-963f-d9cf1264401c/sist-en-61547-2009 **SIST EN 61547:2009** 

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IEC 61547

Edition 2.0 2009-06

## INTERNATIONAL STANDARD

## NORME INTERNATIONALE

Equipment for general lighting purposes - EMC immunity requirements

Équipements pour l'éclairage à usage général – Exigences concernant l'immunité CEM

SIST EN 61547:2009

https://standards.iteh.ai/catalog/standards/sist/eb73a434-ac23-4d7d-963f-d9cf1264401c/sist-en-61547-2009

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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